

HIGH PRECISION LCR METER USER MANUAL

MCR-6100A

MCR-6200A

MCR-6600A

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Statement: in this paper, the content of the instrument. Our company have the right to the instrument performance, appearance, function, accessories, packing and so on to improve and improve without further instructions! The resulting manual do not agree with instruments of confusion, can contact us through the following ways.

Company: MATRIX TECHNOLOGY INC.

Address: 206, Building D, Huachuangda Culture and Technology Industrial Park, Haihui Road, Bao'an 49th District, Shenzhen, Guangdong, China

TEL: 0086 755 2836 4276

Website: WWW.SZMATRIX.COM

Chapter 1 Instrument inspection and preparation

Please be sure to check the receipt of the instrument, and must understand and have the condition before using the instrument.

1.1 The crates

- After receiving the product, it is found that the packing is badly damaged. Please keep it until it is normal for the whole machine and the accessories.
- Check the machine, if the instrument is damaged, please contact the dealer or the company in charge of the business.
- Please check the attachment, please check the attachment according to the packing list, if the attachment is missing or damaged, please contact your dealer or division to protect your rights and interests.

1.2 Power connection

- (1) Power supply voltage range:
100 ~ 120 Vac (The power supply of the instrument rear panel is selected as 110V display)
198 ~ 242 Vac (The power supply of the instrument rear panel is selected as 220V display)
- (2) Frequency range of power supply: 47 ~ 63 Hz。
- (3) Power supply range: ≥ 50 VA。
- (4) Wire-L、Wire-N、Groud-E should be the same as the power plug of the instrument.

The instrument has been carefully designed to reduce the interference caused by the input of the AC power supply side, but still should try to make it in low noise environment, if you can not avoid, please install the power filter.

Warning: in order to prevent leakage of equipment or artificial damage, the user must ensure that the power supply to the earth ground reliable.

1.3 Fuse and toggle switch

Instrument factory has been equipped with a fuse, the user should use the company equipped with a fuse.

Warning: you should pay attention to the position of the toggle switch is consistent with the power supply voltage range of power on before.

1.4 Environmental requirements

- (1) Please do not use in the dust, vibration, direct sunlight, corrosive gases, such as the use of bad environment.
- (2) Instrument is not used for a long time, please put it in the original packing box or similar to the box in the reservoir is 5 to 40 DEG C temperature, relative humidity is not more than 85% RH of the indoor ventilation, air should not contain harmful impurity in corrosion measurement instrument and should avoid direct sunlight.

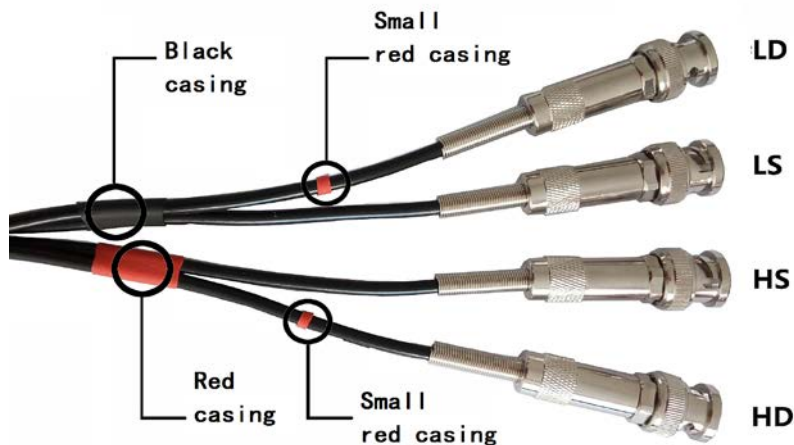
- (3) Please ensure that the instrument is in good ventilation condition, do not plug the instrument cooling and ventilation holes.
- (4) In particular, the instrument is connected with the test wire of the test piece to be far away from the strong electromagnetic field, so as not to interfere with the measurement.

1.5 Test fixture requirements

Please use the company's test fixture or test cable, the instrument test fixture or test cable should be kept clean, the test device pin to keep clean, to ensure that the test device and the fixture is in good contact. The test fixture or test cable is connected to the HD, HS, LS and LD of the front panel of the instrument. The shield layer can be connected to the rear panel of the instrument, and the shield layer can be connected with the rear panel of the instrument.

User homemade or other company test fixtures or test cables may result in incorrect measurement results.

26004-1 Test fixture instructions



1.6 Accuracy guarantee

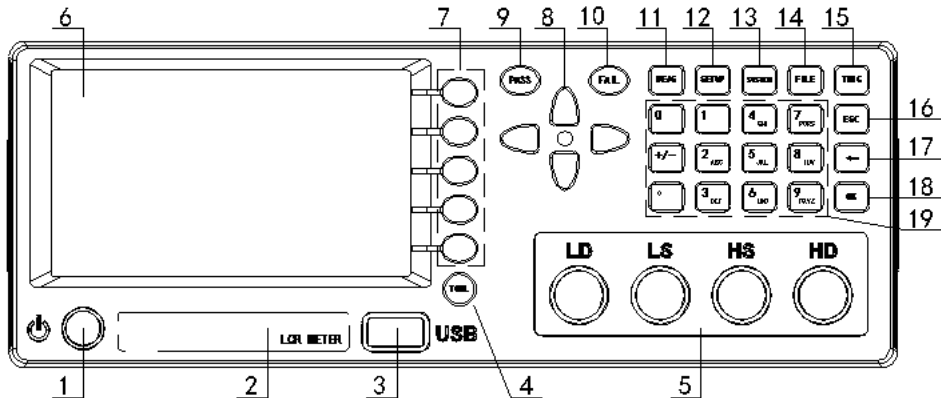
- (1) In order to ensure the accurate measurement of the instrument, the heating time should be no less than 15 minutes.
- (2) Do not frequent switching equipment, in order to avoid confusion caused by internal data.
- (3) Correct open circuit and short circuit operation.

Chapter 2 Introduction

A new generation of high precision and high stability of boutique LCR meter, the 4.3 inch 480*272 TFT display screen, display classical and intuitionistic.

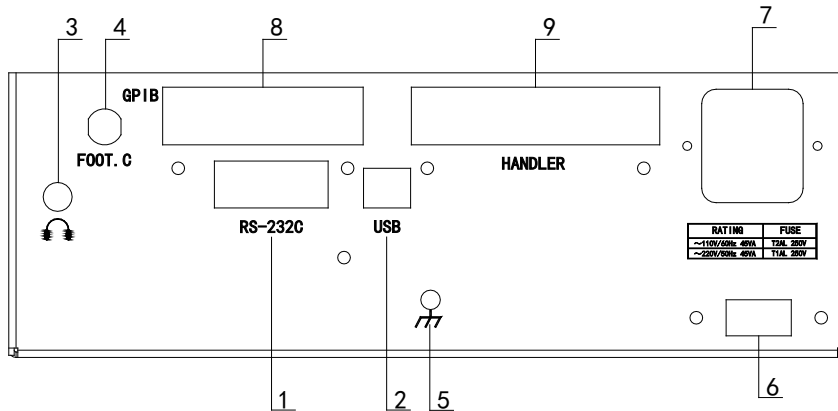
The series of equipment is highly applicable to the majority of manufacturers production inspection. And the series of equipment has a variety of output impedance model can be used for different manufacturers needs, its superior performance can be achieved business standards and military standards of a variety of tests (such as IEC and MIL).

2.1 Front panel description



1. Power switch
2. Instrument type label
3. USB interface
4. Tool key
5. Test terminal: LD、LS、HS、HD
6. 4.3 inch TFT LCD screen
7. Softkey
8. Direction key
9. PASS light, Qualified judgment lamp
10. FAIL light, Failure product judgment lamp
11. MEAS, Measurement display page shortcut key
12. SETUP, Measurement set page shortcut key
13. SYSTEM, System settings page shortcut keys
14. FILE, File management page shortcuts
15. TRIG, Trigger measure key
16. ESC, Cancel key
17. ←, Backspace key, used to delete the previous input
18. OK, Confirm input key
19. Alphanumeric keypad symbols

2.2 Rear panel description



- 1. RS232C, serial port
- 2. USB DEVICE
- 3. Earphone port
- 4. FOOT.C, Foot switch interface
- 5. Ground
- 6. Power switch (110V/220V)
- 7. Power supply socket
- 8. GPIB interface
- 9. HANDLER, Sorting interface

2.3 Basic operation

- 1. Direction key: used to move the cursor.
- 2. Soft keys, used to change the parameters set of features.
- 3. Shortcut menu: MEAS, SETUP, SYSTEM, FILE, press directly into the < MEAS DISPLAY >, < MEASURE SETUP >, < SYSTEM SETUP >, < INTER/EXT Files List > function page settings.

Reminder: when in < MEAS DISPLAY > page, and the cursor in < MEAS DISPLAY >, press MEAS key, < MEAS DISPLAY > page test results will be full screen display.

Cp : -7.29239pF

D : -----

BIN:

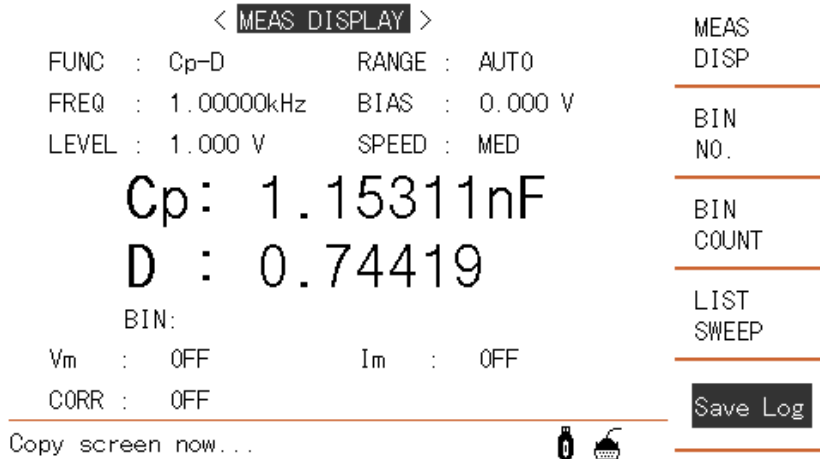
FREQ : 1.00000kHz
 LEVEL : 1.000 V

- 4. TOOL: Tool key, press it to printscreen .

2.4 Each page features

1. MEAS DISPLAY

Press MEAS key to into MEAS DISPLAY page.



The right side of the screen corresponds to the following functions:<MEAS DISP> <BIN NO.> <BIN COUNT> <LIST SWEEP> [Save Log]

Note: [Save Log] key can easily save the test data to U disk in every test page. In the process of saving data, the key is changed to "Save Stop", Users in the preservation of data, if not stop saving and directly pull U disk, data will be lost.

The saved data format is as follows:

- In MEAS DISPLAY, BIN NO. BIN COUNT pages. And if the Comparison is OFF, the <BIN> is not saved.

SN.NNNNNESNN , SN.NNNNNESNN , SN , SN or SNN NL

< Main parameter > < Secondary parameter > < state > <BIN> < Enter >

- In LIST SWEEP page.

SN.NNNNNESNN , SN.NNNNNESNN , SN , SN , N NL

< Main parameter > < Secondary parameter > < state > <Judge> <Dot> < Enter >

Explain:

SN.NNNNNESNN (S: +/-, N: 0 to 9, E: Exponent Sign)

<state>:

state	describe
-1	Data in buffer memory
0	No data
+1	Common measurement data
+2	Unbalanced analog Bridge
+3	A/D conversion does not work
+4	Signal overload or Adjustable constant voltage

<BIN> :

BIN	describe
0	OUT, FAIL no pass
+1	BIN1

+2	BIN 2
+3	BIN 3
+4	BIN 4
+5	BIN 5
+6	BIN 6
+7	BIN 7
+8	BIN 8
+9	BIN 9
+10	AUX

<Judge>:

Judge	describe
-1	Low
0	In, good
+1	High

<Dot>: Current scan point
N (N: 0 到 9)

● In Multi DISPLAY

SN.NNNNNNESNN , SN.NNNNNNESNN , SN.NNNNNNESNN , SN.NNNNNNESNN ,
SN , SN , NL

< Parameter 1> < Parameter 2>< Parameter 3>< Parameter 4> <state> <Judge>
<Enter>

The functions of MEAS DISPLAY are described as following:

FUNC: to select the test parameter.

RANGE: to select the test range.

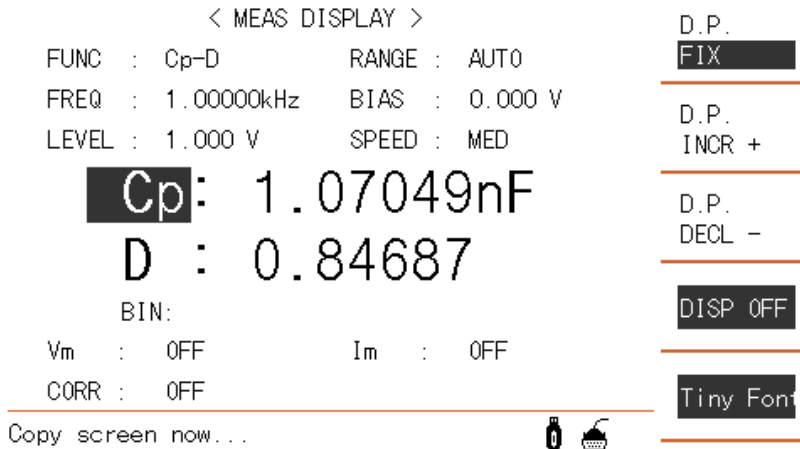
FREQ: to select or write the test frequency.

BIAS: to select the BIAS voltage ,and press the BIAS ON key to open ,press the BIAS OFF key to close.

LEVEL:to select or write the test voltage or current .

SPEED:to select the test speed.

If the cursor is in here as follow, the function is described as following:



D.P. FIX :Press this key to lock decimal,and the key change to D.P.AUTO. And press it again,unlock decimal,and the key change to D.P.FIX

D.P. INCR + :Press this key to increase Decimal.

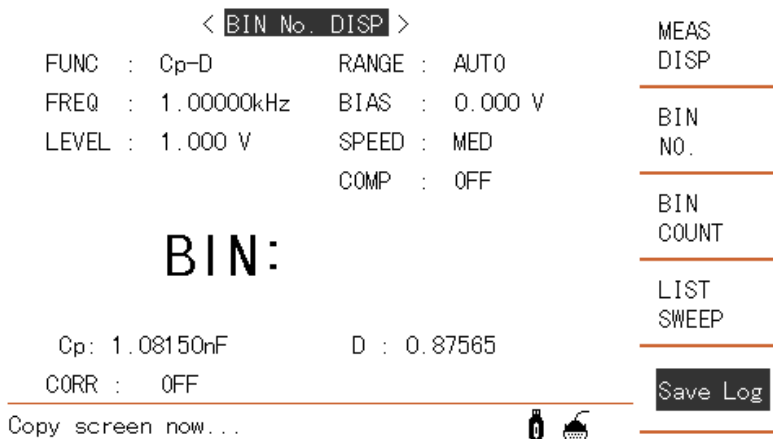
D.P. DECL - :Press this key to decrease decimal.

DISP OFF :Press this key to close display data,and the key change to DISP ON.And press it again to open display data.

Tiny Font:Press it to display font reduction,and this key change to Big Font.And prss it again to restore display font.

2. BIN No.DISP

Press BIN NO. key to BIN No.DISP page .



< BIN No. DISP >

FUNC : Cp-D	RANGE : AUTO	ON
FREQ : 1.00000kHz	BIAS : 0.000 V	_____
LEVEL : 1.000 V	SPEED : MED	OFF
	COMP : OFF	_____

BIN:

Cp: 1.45740nF	D : 1.00914	_____
CORR : OFF		_____

Copy screen now...

This page display the comparison results .We can select COMP ON to open comparison function ,or select COMP OFF to close comparison function.

3. BIN COUNT DISP

Press BIN COUNT key to BIN COUNT DISP page.

< BIN COUNT DISP >

PARAM: Cp-D	NOM. : 0.00000pF	COUNT: OFF	MEAS DISP
BIN	LOW [F]	HIGH[F]	COUNT
1			0
2			0
3			0
4			0
5			0
6			0
7			0
8			0
9			0
2nd		[]	
AUX : OFF		OUT : 0	Save Log

Copy screen now...

This page is used to record the number of every BIN that have been tested. Move cursor to COUNT:OFF,can select ON or OFF key to open or close COUNT function. Select RESET COUNT key to set COUNT to 0 .

< BIN COUNT DISP >

PARAM: Cp-D	NOM. : 0.00000pF	COUNT: OFF	ON
BIN	LOW [F]	HIGH[F]	COUNT
1			0
2			0
3			0
4			0
5			0
6			0
7			0
8			0
9			0
2nd		[]	
AUX : OFF		OUT : 0	RESET COUNT

Copy screen now...

4. LIST SWEEP DISP

Press LIST SWEEP key to LIST SWEEP DISP page.



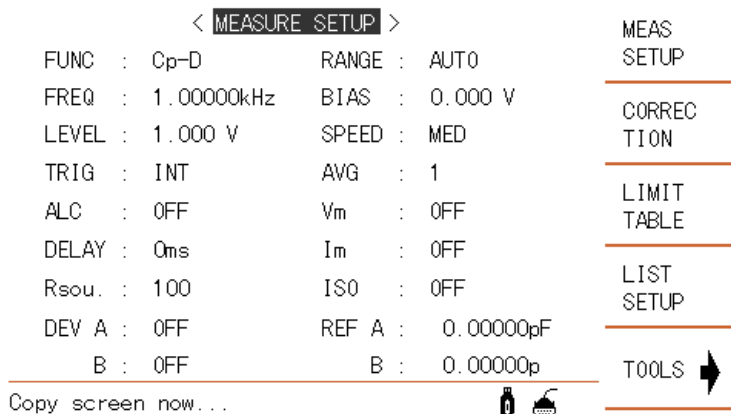
The function of this page: MEODE .

Move cursor to MODE,select SEQ or STEP mode .If we select SEQ and the Trigger mode is MAN or EXT,all list dots will be tested when we trig the meter . And if we select STEP and the Trigger mode is MAN or EXT,only one dot will be tested when we trig the meter.



5. MEASURE SETUP

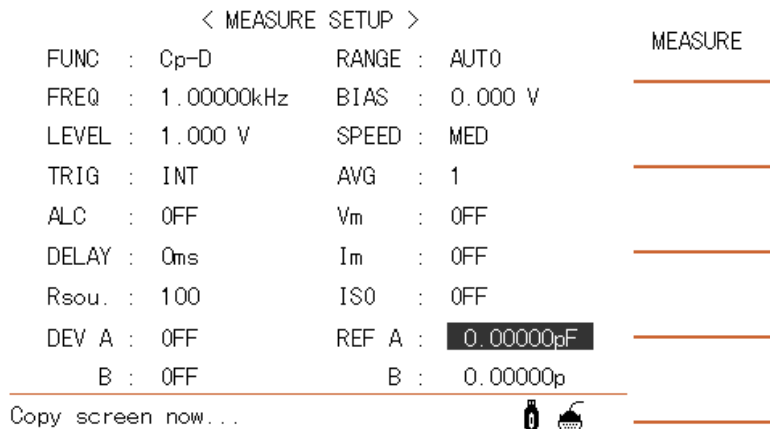
Press SETUP key to MEASURE SETUP page.



The functions of MEASURE SETUP page are described as following:



FUNC: to select the test parameter.

- RANGE:** to select the test range.
- FREQ:** to select or write the test frequency.
- BIAS:** to select the BIAS voltage ,and press the BIAS ON key to open ,press the BIAS OFF key to close.
- LEVEL:**to select or write the test voltage or current .
- SPEED:**to select the test speed.
- TRIG:** to select the trigger mode. Test automatically when we select INT. Only test one time when we press TRIG key and the trigger mode is MAN. Only test on time when the meter give a trigger signal if we select the trigger mode EXT.
- AVG:** 1~255 . The results of the test are displayed on average
- ALC:** Select ON to open constant level test,select OFF to close this function.
- DELAY:**0~60s .It's the delay test time .
- Vm:**Select ON to monitor test voltage.And select OFF to close this function.
- Im:**Select ON to monitor test current.And select OFF to close this function.
- Rsou:** To select internal resistance mode . 100,30,10/100,10/CC
- ISO:** Isolation mode. This function is always open.
- DEV A:** Main parameter display mode.
B: Sub parameter display mode.
- REF A:** Main parameter reference value.We can input it or press MEASURE key to get a test value.
B: Sub parameter reference value.We can input it or press MEASURE key to get a test value.



TOOLS: We can press this key in MEASURE SETUP page.the screen will display the following:

< MEASURE SETUP >		CLEAR SETUP
FUNC : Cp-D	RANGE : AUTO	
FREQ : 1.00000kHz	BIAS : 0.000 V	
LEVEL : 1.000 V	SPEED : MED	
TRIG : INT	AVG : 1	
ALC : OFF	Vm : OFF	
DELAY : 0 ms	Im : OFF	
Rsou. : 100	ISO : OFF	
DEV A : OFF	REF A : 0.00000pF	
B : OFF	B : 0.00000p	←



Copy screen now...  

If we press CLEAR SETUP key,all settings will be restored to default settings.

6. CORRECTION

Press CORRECTION key to CORRECTION page.



< CORRECTION >		MEAS SETUP
OPEN : OFF	CABLE : 0m	
SHORT : OFF	MODE : Single	
LOAD : OFF	CH No. : ----	CORRECTION
	FUNC : Cp-D	
FREQ 1: OFF	B: -----	LIMIT TABLE
REF A: -----	B: -----	
MEA A: -----		
FREQ 2: OFF	B: -----	LIST SETUP
REF A: -----	B: -----	
MEA A: -----		
FREQ 3: OFF	B: -----	
REF A: -----	B: -----	
MEA A: -----	B: -----	

Copy screen now...  

The functions of CORRECTION page are described as following:

OPEN:Move cursor to here. Page displays as follows

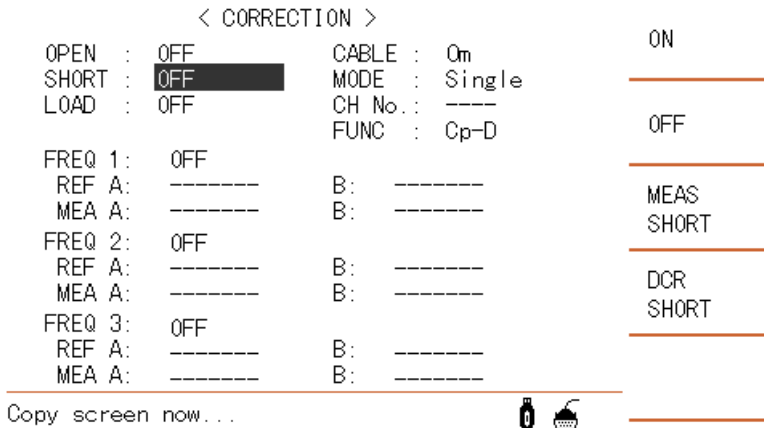
< CORRECTION >		ON
OPEN : OFF	CABLE : 0m	
SHORT : OFF	MODE : Single	
LOAD : OFF	CH No. : ----	OFF
	FUNC : Cp-D	
FREQ 1: OFF	B: -----	MEAS OPEN
REF A: -----	B: -----	
MEA A: -----		
FREQ 2: OFF	B: -----	DCR OPEN
REF A: -----	B: -----	
MEA A: -----	B: -----	
FREQ 3: OFF	B: -----	
REF A: -----	B: -----	
MEA A: -----	B: -----	

Copy screen now...  

Press ON key to open the OPEN function. Press OFF key to close the OPEN function. Keep the test fixture open,then press MEAS OPEN key to do open circuit correction for

all frequency. Keep the test fixture open,then press DCR OPEN key to do open circuit correction about DCR .

SHORT: Move cursor to here. Page displays as follows



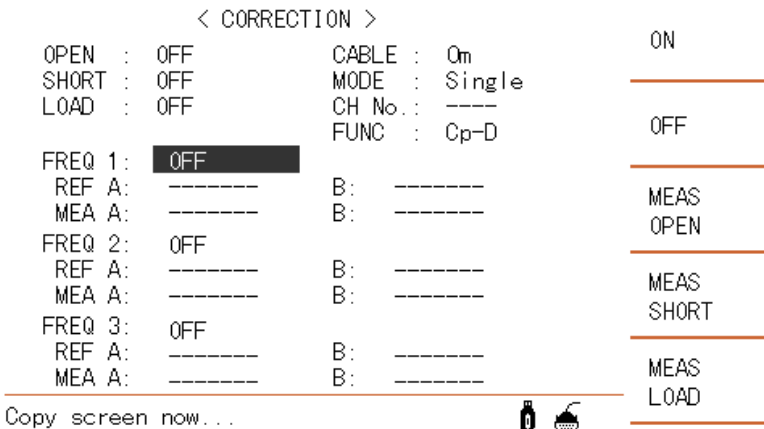
Press ON key to open the SHORT function. Press OFF key to close the SHORT function. Keep the test fixture short,then press MEAS SHORT key to do short circuit correction for all frequency. Keep the test fixture short,then press DCR SHORT key to do short circuit correction about DCR .

LOAD: Move cursor to here. Select ON key to open LOAD correction .Select OFF key to close LOAD correction.

CABLE,MODE,CH No. : Can not choose.

FUNC: Select the parameters to be corrected for load correction.

FREQ1,FREQ2,FREQ3: Move cursor to here. Page displays as follows

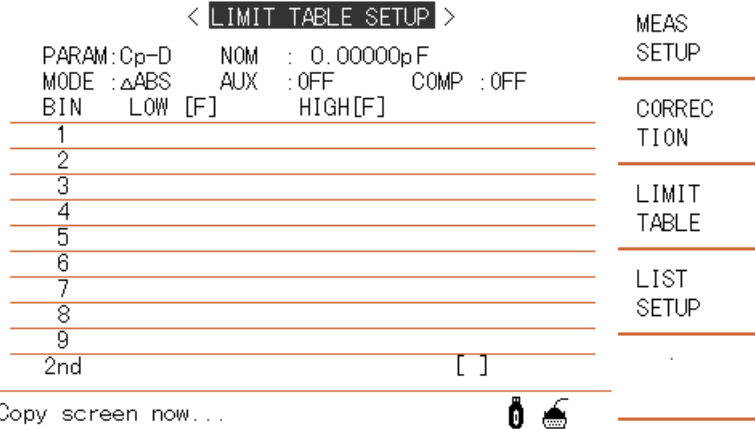


Press ON key to open the correction for this frequency.We can input the test frequency here. And press OFF key to close the correction. Keep the test fixture open,then press MEAS OPEN key to do open circuit correction for this frequency. Keep the test fixture short,then press MEAS SHORT key to do short circuit correction for this frequency. MEAS LOAD key must be used with REF A and B, otherwise it is easy to make mistakes.If we want to do load correction,we must move cursor to REF A and B first. Then we should input the reference value in REF A and B.Then move cursor to FREQ1,FREQ2 or FREQ3. Make test fixture reliable clamping standard parts,then press MEAS LOAD key to do load

correction.

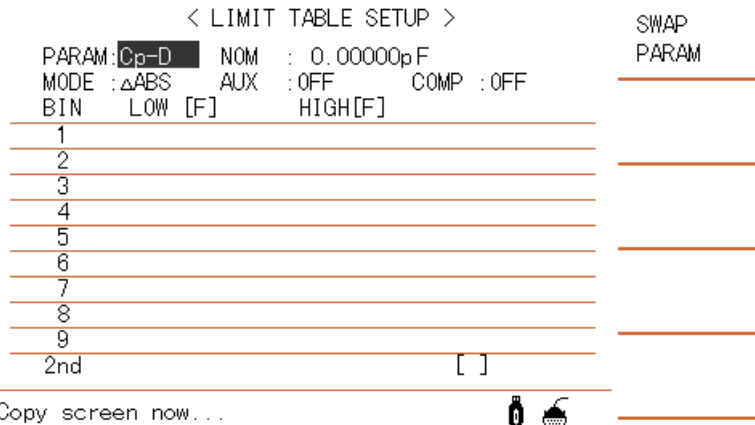
7. LIMIT TABLE SETUP

Press LIMIT TABLE key to LIMIT TABLE SETUP page.



The functions of LIMIT TABLE SETUP page are described as following:

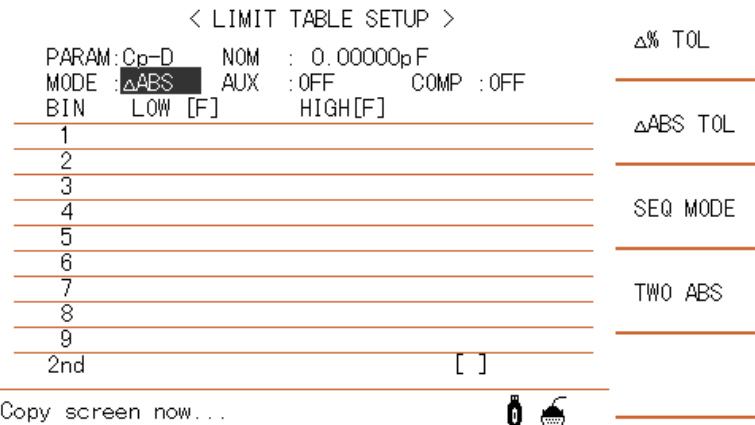
PARAM: Move cursor to here . Page displays as follows



If we press SWAP PARAM key , the primary and secondary parameters will be interchanged .Press SWAP PARAM key again, return to normal.

NOM: Input nominal value,here.

MODE: There are four mode,here.Move cursor to here. Page displays as follows

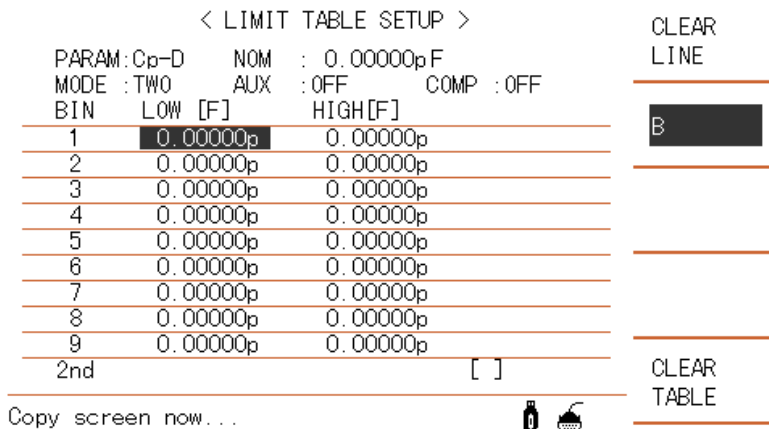
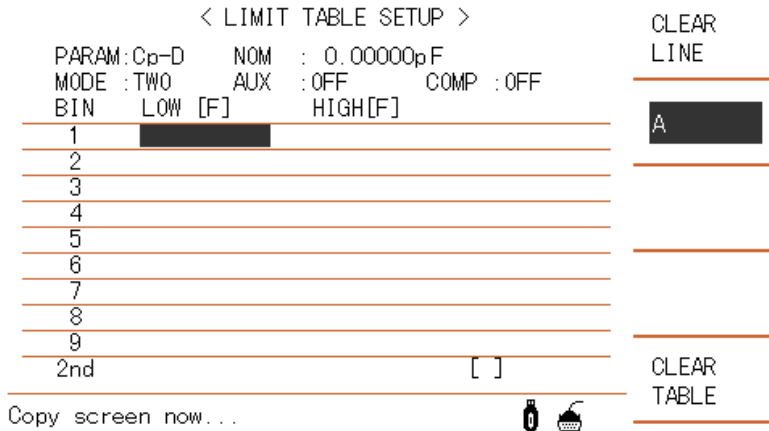


Δ% TOL :For example,if the lower limit is -10%, then only need to enter LOW in -10% . if the higher limit is +10%, then only need to enter HIGH in 10% .

ΔABS TOL: Relative absolute deviation. For example ,if the data is 2pF±0.2pF,then only need to enter LOW in -0.2pF,and to enter HIGH in 0.2pF.

SEQ MODE: BIN1's HIGH is BIN2's LOW, BIN2's HIGH is BIN3's LOW, and so on.

TWO ABS: The primary and secondary parameters are compared with absolute values. There are 9 BIN in primary and secondary parameters.



AUX: Auxiliary alarm. The main parameters are qualified, but the secondary parameters are not qualified.Press ON to open AUX,and press OFF to close it.

COMP: Comparison switch. Only open the switch, the data will be compared to determine.Press ON to open it,and press OFF to close it.

BIN,LOW,HIGH : Input the upper and lower limits in these tables.

8. LIST SWEEP SETUP

Press LIST SETUP key to LIST SWEEP SETUP page.



Move cursor to MODE,select SEQ or STEP mode .If we select SEQ and the Trigger mode is MAN or EXT,all list dots will be tested when we trig the meter . And if we select STEP and the Trigger mode is MAN or EXT,only one dot will be tested when we trig the meter.

Attention: The settings page cannot be tested and must be tested under the display page.

FREQ[Hz]: Move cursor to here,we can select which we want to test.



Select FREQ[Hz] key to do frequency test .Select LEVEL[V] to do voltage test.Select LEVEL[A] to do current test.



Move cursor to tables,as shown above.We can select DELETE LINE key to delete the data of the table.And we can select CLEAR TABLE key to delete data of all tables.And we can input the test condition in this table.Move cursor to LMT table,page displays as follows.



If we select LIMIT DATA A key, the upper and lower limits of the main parameters are compared.If we select LIMIT DATA B key, the upper and lower limits of the secondary parameters are compared.If we select OFF key, it does not compare. LOW,HIGH:input the lower or upper limits .

9. SYSTEM SETUP

Press SYSTEM key on the instrument panel to SYSTEM SETUP page.

< SYSTEM SETUP >

THEME : TRAD BLUE
 KEY SOUND : HIGH
 语言 : English
 PASS WORD : OFF
 DATE : 2017 - 04 - 07
 TIME : 02 : 08 : 55
 PARA SAVE : AUTO SAVE

SYSTEM
SETUPTEST
SETUPCOMM
SETUPABOUT
SYSTEM

Copy screen now...



The functions of SYSTEM SETUP page are described as following:

THEME: System display style .There are TRAD BLUE and TRAD BLACK .

KEY SOUND: Key sound selection.If we select OFF, then the key sound is turned off. If we select ON, then the key sound is turned on.

LANGUAGE: Instrument display language. There are two languages, one is English, the other is Chinese .

PASS WORD: Password protection function. Page are described as following:

< SYSTEM SETUP >

THEME : TRAD BLUE
 KEY SOUND : HIGH
 语言 : English
 PASS WORD : OFF
 DATE : 2017 - 04 - 07
 TIME : 04 : 02 : 25
 PARA SAVE : AUTO SAVE

OFF

LOCK
SYSTEMLOCK
FILE

MODIFY

SaveTo
U_DISK

Copy screen now...



Press OFF key to close passworded protection function.

LOCK SYSTEM: System encryption . If we select this,we should input the password when boot . And we should input the password when we want to LOAD file or STORE file ,or DELTE file .

LOCK FILE: File encryption . If we select this, we should input the password when we want to LOAD file or STORE file ,or DELTE file .

MODIFY: Modify password.If we want to modify password,we should input the old password first,then input the new password ,and input the new password again to confirm it.

SaveTo U_DISK: Save password to U disk. When you need to enter a password, you only need to insert the U disk on it.

Factory default password: Different models of the factory password is not the same.

MCR-6100A:6100

MCR-6200A:6200

MCR-6600A:6600

DATE: Date display and modification.

TIME: Time display and modification.

PARA SAVE: Parameter save mode. When selecting the AUTO SAVE mode, the boot will automatically load the state parameter before the last shutdown. When selecting the AUTO LOAD mode, the boot will automatically load the first file in the Files List page . When the file does not exist, the default factory settings are displayed.

10. TEST SETUP

Press TEST SETUP key to TEST SETUP page.



The functions of TEST SETUP page are described as following:

SYSTEM FUNC: Select normal LCR test mode and multi parameter test mode.Press LCR key to select normal LCR test mode. Press MULTI PARA.key to select multi parameter test mode.

BEEPER: Buzzer select. There are three kinds.MASTER,AUXILIARY,EARPHONE .

PASS BEEP: Sound selection for PASS .Select OFF to close it. Select others to Open.

FAIL BEEP: Sound selection for FAIL . Select OFF to close it. Select others to Open.

BiasSource: Bias source selection.Select INT mode,only 0V,1.5V,2V .Select EXT mode , can be used together supporting the external bias current source.

HANDLER MODE: Handler mode selection.

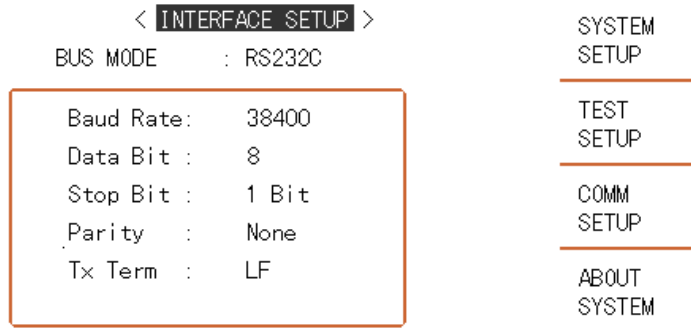
CLEAR: When the instrument receives the trigger signal, the comparison signal is reset,and output after the test.

HOLD: Maintain the comparison signal until the signal changes.

TRIGGER EDGE: Trigger edge selection.There are Rising Edge and Falling Edge.

11. INTERFACE SETUP

Press COMM SETUP key to INTERFACE SETUP page.



Copy screen now...



The functions of INTERFACE SETUP page are described as following:

BUS MODE: Move cursor to here. We can select the interface mode. There are RS232C, GPIB, USBTMC and USB CDC.

A. RS232C

Baud Rate: Baud rate must be the same as the computer serial port baud rate.

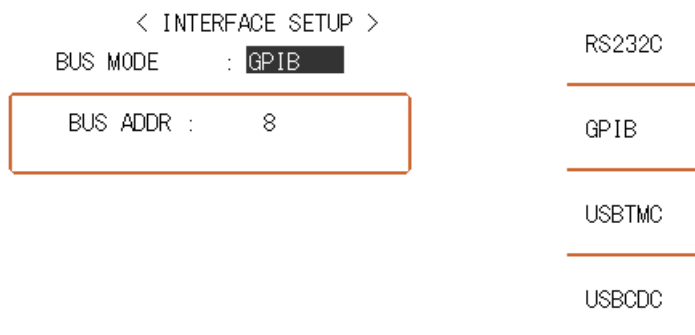
Data Bit : 6, 7, 8

Stop Bit: 1, 1.5, 2

Parity : None, Odd check, Even parity

Tx Term : LF, CR, LFCR (ASCII: LF(0x0A), CR(0x0D))

B. GPIB



Copy screen now...



BUS ADDR: Bus address. 0~31

C. USBTMC

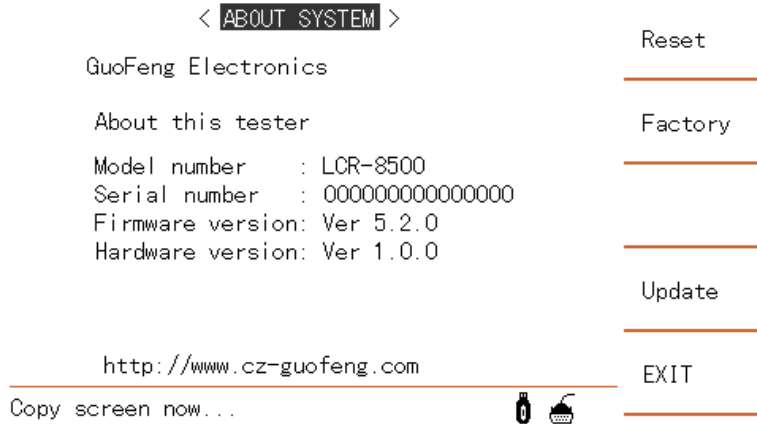
The model can be controlled by the USBTMC standard protocol, such as the control of the GPIB interface instrument to control the USB interface instrument.

D. USB CDC

In this mode, the USB communication port of the instrument is used as serial port.

12. ABOUT SYSTEM

Press ABOUT SYSTEM key to ABOUT SYSTEM page.



This page displays the instrument identity information and some system functions.

Function keys are as follows:

Reset: Press Reset key to restart the instrument.

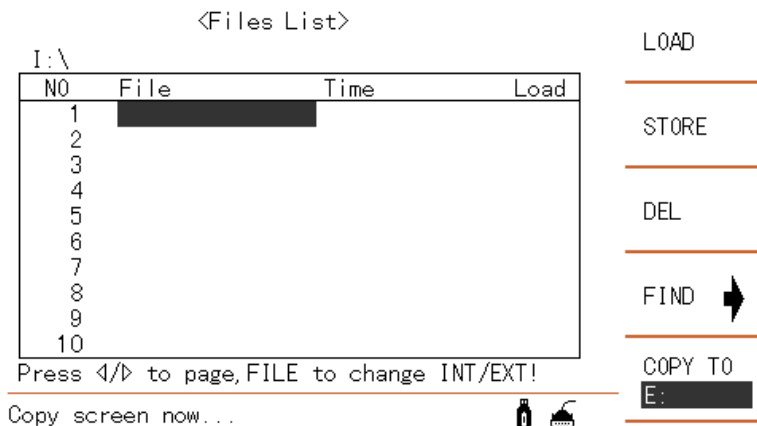
Factory: Press Factory key to reload the factory settings. Use this feature, you need to enter the password through the screen prompt.

Update: Press Update key to upgrade the system. Insert the U disk with the upgrade file according to the screen prompt.

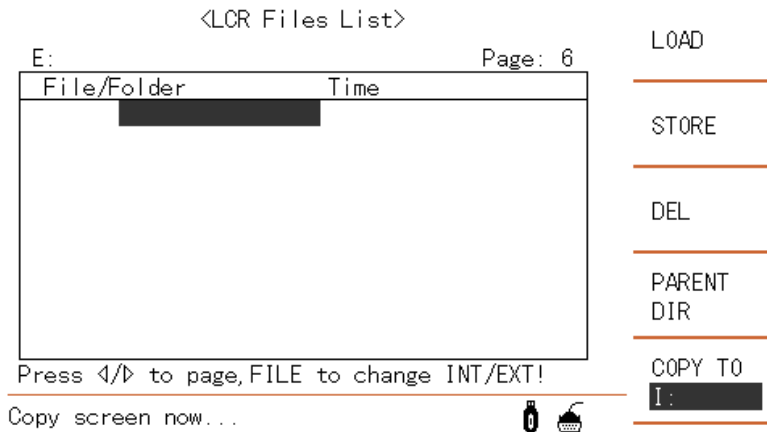
EXIT: Return to previous menu page.

13. FILE

Press FILE key to Files List page.



Press FILE key again to LCR Files List page. This page is the U disk.



The parameters set by the user in form of a file stored in the instrument internal non-volatile memory, when the next time you want to use the same settings, users do not need to set these parameters, only need to load the appropriate file, the last set of parameters are obtained. Thus greatly saving the time for the user to re set the parameters and improving the production efficiency.

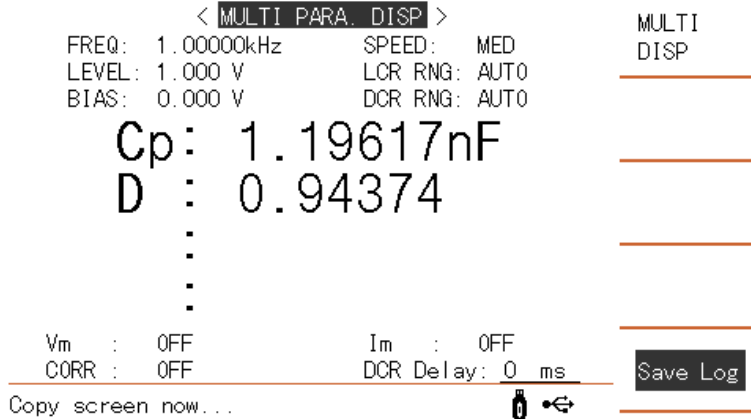
Operation procedure description:

- A. Review existing files
 - 1) By using the upper and lower keys, one by one look.
 - 2) Use the left and right buttons, can look at the page.
 - 3) Input file number keys corresponding to the serial number, then press the button [OK], can be directly read the required file.
- B. Follow these steps to save the parameter to the file.
 - 1) The number at the cursor to need to save the file, press [STORE] softkey;
 - 2) Select softkey [YES] into the next step, select the key [NO] cancel the save operation;
 - 3) If step 2) select [YES], use the numeric keys to enter the file name and press [OK] to confirm. If the serial number is already in the file, you can override the file or cancel the operation according to the screen.
- C. Follow these steps to load the parameters set in the corresponding file.
 - 1) Press the FILE key to switch to the file management page.
 - 2) Move the cursor to the file location in the file list, or direct input file serial number.
 - 3) Press LOAD key.
 - 4) Select softkey YES, loading the current file, and return to the current page.
- D. Follow the steps for copying files to E (U disk).
 - 1) Insert the U disk into the instrument front panel USB interface.
 - 2) Move the cursor to the file, press the soft key "copy to E:"
 - 3) According to the screen, press the soft key "YES" to copy.
 - 4) If U disk file with the same file name, screen prompt the need to cover, according to the soft key "YES" to continue copying, press the soft key "NO", cancel the copy.

14. MULTI PARA DISP

If we select the SYSTEM FUNC as MULTI PARA in TEST SETUP page, then press MEAS

key to MULTI PARA DISP page.



The functions of MULTI PARA DISP page are described as following:

FREQ: to select or write the test frequency.

LEVEL: to select or write the test voltage or current .

BIAS: to select the BIAS voltage ,and press the BIAS ON key to open ,press the BIAS OFF key to close.

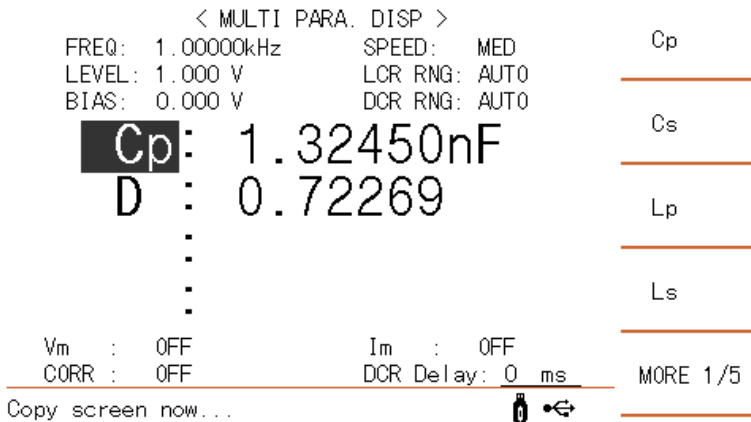
SPEED: to select the test speed.

LCR RNG: to select the LCR test range.

DCR RNG: to select the DCR test range.

DCR Delay: to input the delay time of DCR test.

Move cursor to parameter,we can select the test parameter.



15. MULTI PARA SETUP

Now press SETUP key on the instrument panel to MULTI PARA SETUP page.

< MULTI PARA. SETUP >				
MODE: ΔABS				MEAS SETUP
FUNC	NOM	LOW	HIGH	CORREC TION
Cp				
D				MULTI SETUP

Copy screen now...



The functions of MULTI PARA SETUP page are described as following:

MODE: Move cursor to here to select compare mode.

< MULTI PARA. SETUP >				
MODE: ΔABS				ΔABS
FUNC	NOM	LOW	HIGH	Δ %
Cp				
D				

Copy screen now...



CLEAR
TABLE

ΔABS: If $(NOM+LOW) \leq \text{Data of test} \leq (NOM + HIGH)$,it is PASS,otherwise it is FAIL .

Δ% : If $NOM*(1+LOW) \leq \text{Data of test} \leq NOM*(1 + HIGH)$,it is PASS,otherwise it is FAIL .

CLEAR TABLE: Press this key to clear data of all tables.

FUNC: In this table,we can select the test parameter.

NOM : In this table, we can input the nominal values for each test parameter.

LOW : In this table, we can input the lower limit for each test parameter.

HIGH: In this table,we can input the upper limit for each test parameter.

Chapter 3 Performance

Accuracy

The accuracy of $|Z|, L, C, R, X$

The accuracy of A_e about $|Z|, L, C, R, X$ is expressed by the following formula:

$$A_e = \pm[A + (K_a + K_b + K_f) \times 100 + K_c] \times K_c \quad [\%]$$

A: Basic measurement accuracy (See Figure 3-1)

K_a: Impedance scaling factor (See table 3-4), when using the impedance is less than

500 ohm .

K_b : Impedance scaling factor (See table 3-4), when using the impedance is greater than 500 ohm.

K_c : Temperature factor (See table 3-5)

K_f : Calibrated interpolation factor (See table 3-6)

K_l : Cable length factor (See table 3-7)

Ⓛ Be careful: According to the impedance size, it is only one valid about K_b and K_a , and the other one is replaced by 0.

L, C, X accuracy conditions: D_x (Measured value of D) ≤ 0.1

R accuracy conditions: Q_x (Measured value of Q) ≤ 0.1

When $D_x \geq 0.1$, A_e of L, C, X: $A_e = A_e * \sqrt{1 + D_x^2}$

When $Q_x \geq 0.1$, A_e of R: $A_e = A_e * \sqrt{1 + Q_x^2}$

Accuracy of D

The accuracy of D_e about D is expressed by the following formula:

$$D_e = \pm \frac{A_e}{100}$$

When $D_x \leq 0.1$, $D_e = D_e$

When $D_x > 0.1$, $D_e = D_e * (1 + D_x)$

Accuracy of Q

The accuracy of Q_e about Q is expressed by the following formula:

$$Q_e = \pm \frac{Q_x \times D_e}{1 \mp Q_x \times D_e}$$

Here, Q_x is the test value of Q.

D_e is the accuracy of D

It is effective, when $Q_x \times D_e < 1$

Accuracy of θ

The accuracy of θ is expressed by the following formula:

$$\theta_e = \frac{180}{\pi} \times \frac{A_e}{100} \quad [\text{deg}]$$

Accuracy of R_p

When $D_x \leq 0.1$, the accuracy of R_p is expressed by the following formula:

$$R_p = \pm \frac{R_{px} \times D_e}{D_x \mp D_e} \quad [\Omega]$$

Here, R_{px} is the test value of R_p . $[\Omega]$

D_x is the test value of D.

D_e is the accuracy of D

Accuracy of R_s

When $D_x \leq 0.1$, the accuracy of R_s is expressed by the following formula:

$$R_{se} = X_x \times D_e \quad [\Omega]$$

$$X_x = 2\pi f L_x = \frac{1}{2\pi f C_x}$$

Here, X_x is the test value of X. [S]

C_x is the test value of C. [F]

L_x is the test value of L. [H]

D_e is the accuracy of D, f is the test frequency.

Accuracy factor

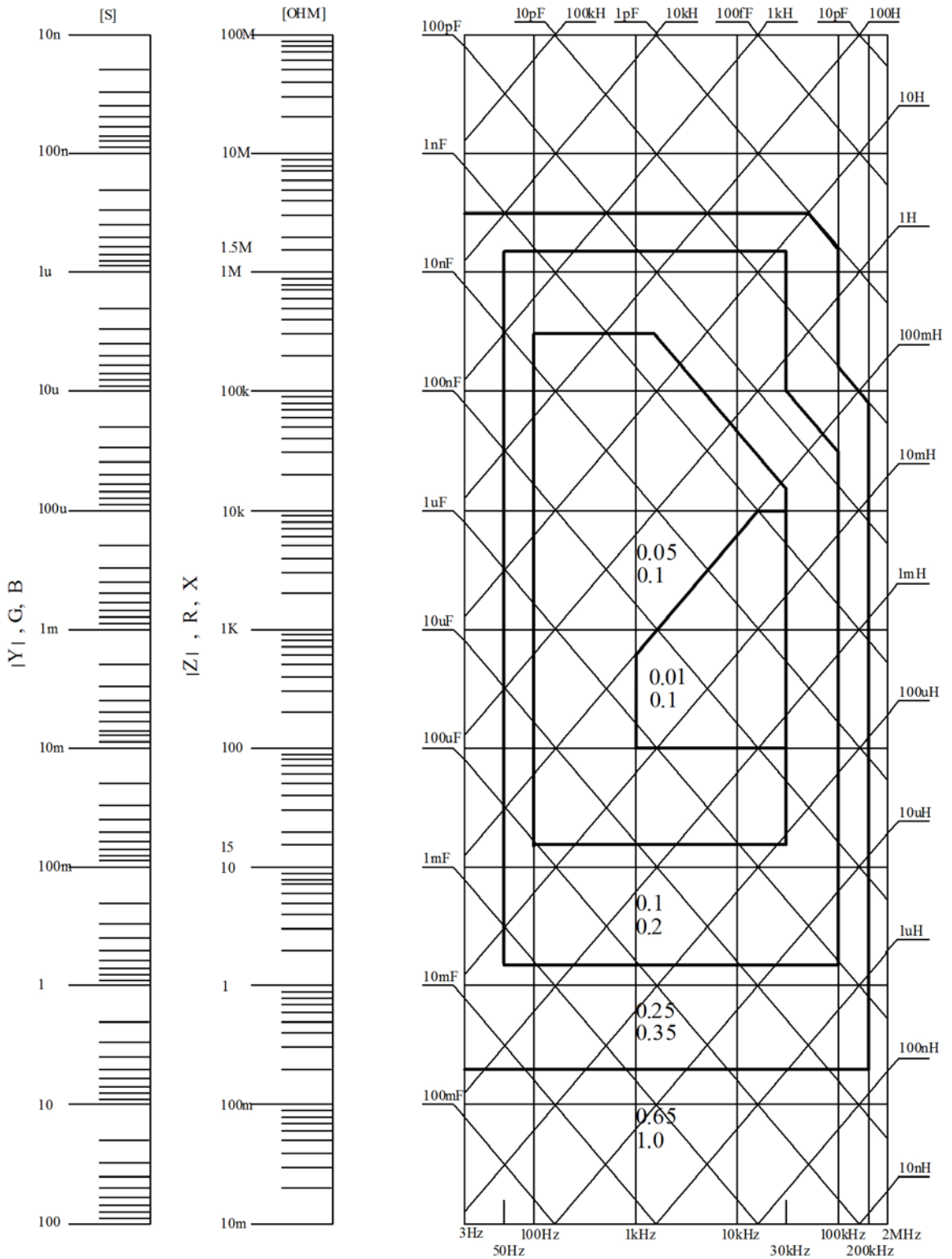


Figure 3-1 Basic measurement accuracy: A

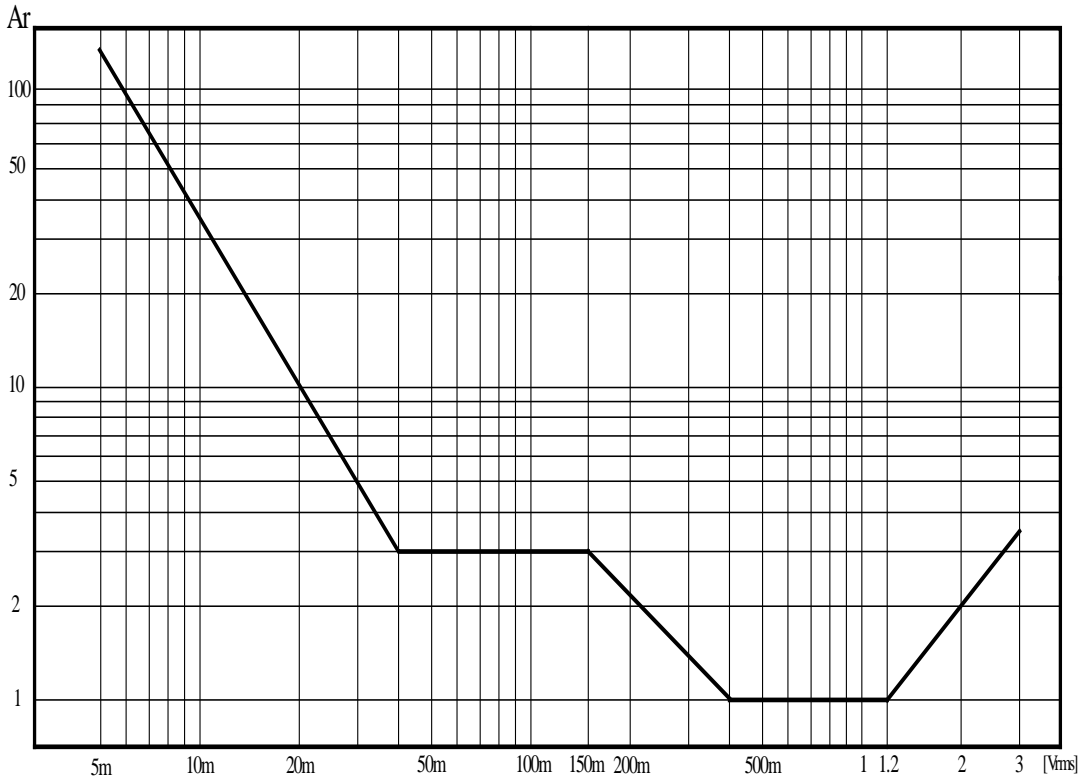
Figure 3-1, in the junction line, can choose a smaller value. Figure 3-1, the value of the

basic accuracy A selection method is as follows:

0.01 (Smaller value) is the value of A ,when $0.4V_{rms} \leq V_s \leq 1.2V_{rms}$ and the test speed is SLOW or MED.

0.1 (Larger value) is the value of A ,when $0.4V_{rms} \leq V_s \leq 1.2V_{rms}$ and the test speed is FAST .

Test level correction factor: Ar, According to Figure 3-1 select the basic accuracy A, A multiplied by Ar to get the level correction of the basic measurement accuracy. Here, Vs is the test signal voltage.



Basic accuracy level correction factor

Table 3-4 Impedance scaling factor : K_a 、 K_b

speed	frequency	K_a ($Z_m < 500\Omega$)	K_b ($Z_m > 500\Omega$)
MED, SLOW	$f_m < 100\text{Hz}$	$(\frac{1 \times 10^{-3}}{ Z_m })(1 + \frac{200}{V_s})(1 + \sqrt{\frac{100}{f_m}})$	$ Z_m (1 \times 10^{-9})(1 + \frac{70}{V_s})(1 + \sqrt{\frac{100}{f_m}})$
	$100\text{Hz} \leq f_m \leq 100\text{kHz}$	$(\frac{1 \times 10^{-3}}{ Z_m })(1 + \frac{200}{V_s})$	$ Z_m (1 \times 10^{-9})(1 + \frac{70}{V_s})$
	$f_m > 100\text{kHz}$	$(\frac{1 \times 10^{-3}}{ Z_m })(2 + \frac{200}{V_s})$	$ Z_m (3 \times 10^{-9})(1 + \frac{70}{V_s})$
FAST	$f_m < 100\text{Hz}$	$(\frac{2.5 \times 10^{-3}}{ Z_m })(1 + \frac{400}{V_s})(1 + \sqrt{\frac{100}{f_m}})$	$ Z_m (2 \times 10^{-9})(1 + \frac{100}{V_s})(1 + \sqrt{\frac{100}{f_m}})$

100Hz ≤ fm ≤ 100kHz	$(\frac{2.5 \times 10^{-3}}{ Z_m })(1 + \frac{400}{V_s})$	$ Z_m (2 \times 10^{-9})(1 + \frac{100}{V_s})$
fm > 100kHz	$(\frac{2.5 \times 10^{-3}}{ Z_m })(2 + \frac{400}{V_s})$	$ Z_m (6 \times 10^{-9})(1 + \frac{100}{V_s})$

Here, fm: Test frequency . [Hz]

Zm: Measured impedance. [Ω]

Vs: Test signal voltage .[mV_{rms}]

Table 3-5 Temperature factor: K_c

Temperature (°C)	5	8	18	28	38	
K _c	6	4	2	1	2	4

Table 3-6 Calibrated interpolation factor : Kf

Test frequency	Kf
Typical frequency (Direct calibration)	0
Atypical frequency (Interpolation calibration)	0.0003

Note:At present, all types of frequency point is the typical frequency.

Table 3-7 Cable length factor

Test signal level	Cable length		
	0m	1m	2m
0.1V _{rms} ,0.3V _{rms}	0	$2.5 \times 10^{-4}(1+0.05fm)$	$5 \times 10^{-4}(1+0.05fm)$
1V _{rms}	0	$2.5 \times 10^{-3}(1+0.016fm)$	$5 \times 10^{-3}(1+0.05fm)$

Here, fm is the test signal frequency. [kHz]

Appendix: Parameter list

Test frequency	MCR-6100A: 12Hz – 100kHz, Minimum 0.0001Hz step MCR-6200A: 12Hz – 200kHz, Minimum 0.0001Hz step MCR-6600A: 12Hz – 600kHz, Minimum 0.0001Hz step
parameter	Z , Y , C, L, X, B, R, G, D, Q, θ ,DCR

Basic accuracy	0.01% , (0.1% for DCR test)
equivalent circuit	Series & parallel
Mathematics function	Absolute deviation, Percentage deviation
Range	Auto, Hold, Manual selection
Trigger mode	INT, MAN, EXT, BUS
Speed ($\geq 1\text{kHz}$)	FAST: 75 times/second, MED: 12 times/second, SLOW: 3 times/second
Average	1—255
Delay Time	0—60s
Calibration	open / short / load
Test terminal	Five terminal
List scan	10 point list scanning function (4 point list for GF100A GF200LA GF200A)
Comparative function	eleven BIN sorting function (BIN1~BIN9,AUX,OUT) six BIN sorting function (BIN1~BIN4,AUX,OUT) for GF100A GF200LA GF200A
Multi parameter test	Yes
Display mode	Direct, Δ , $\Delta\%$, V/I
Monitor	480 x 272 RGB, 4.3 inch, 16: 9 LCD TFT display
Output impedance	30 Ω , 100 Ω , 10 /100, 10 /CC
Test level	5 mV – 2V , Accuracy: 10% Constant level: 10 mV – 1 V Accuracy: 5%
DC bias source	0V, 1.5V, 2V, Accuracy: 1%
Display range	
Z , R, X	0.01m Ω — 99.9999 M Ω
DCR	0.001 m Ω — 99.9999 M Ω
Y , G, B	0.00001 μS — 99.9999S
C	0.00001pF — 9.99999F
L	0.00001 μH — 99.9999kH
D	0.00001 — 9.99999
Q	0.00001 — 99999.9
θ (DEG)	-179.999° — 179.999°
θ (RAD)	-3.14159 — 3.14159
Others	
size	265mm(W) *100mm (H) *340mm(L)
suttle	About 4.5 kg